



N-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY							
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^a	Q _g (Typ.)				
20	0.080 at V _{GS} = 4.5 V	2.8					
	0.090 at $V_{GS} = 2.5 \text{ V}$	2.6	3.2 nC				
	0.105 at V _{GS} = 1.8 V	2.4	3.2110				
	0.150 at V _{GS} = 1.5 V	2.0					

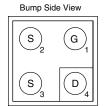
FEATURES

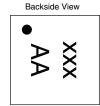
- TrenchFET® Power MOSFET
- Ultra Small 0.8 mm x 0.8 mm Outline
- Ultra Thin 0.357 mm Height
- Typical ESD Protection 1500 V
- Material categorization: For definitions of compliance please see www.vishav.com/doc?99912



HALOGEN FREE

MICRO FOOT



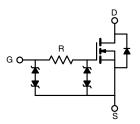


Device Marking: xxx = Date/Lot Traceability Code

Ordering Information: Si8800EDB-T2-E1 (Lead (Pb)-free and Halogen-free)

APPLICATIONS

- Portable Devices such as Cell Phones, Smart Phones and MP3 Players
 - Load Switch
 - Small Signal Switch



ABSOLUTE MAXIMUM RATIN	IGS (T _A = 25 °C	, unless othe	erwise noted)	
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V_{DS}	20	V
Gate-Source Voltage		V_{GS}	± 8	v
	T _A = 25 °C		2.8 ^a	
Continuous Drain Current (T = 150 °C)	T _A = 70 °C	1 , [2.2 ^a	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	l _D	2 ^b	
	T _A = 70 °C	1	1.6 ^b	A
Pulsed Drain Current		I _{DM}	15	
Osstinus Ossus Busin Binds Ossus	T _A = 25 °C		0.7 ^a	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	0.4 ^b	
	T _A = 25 °C		0.9 ^a	
Maximum Bower Dissipation	T _A = 70 °C]	0.6 ^a	w
Maximum Power Dissipation	T _A = 25 °C	- P _D	0.5 ^b	VV
	T _A = 70 °C	1	0.3 ^b	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C
Soldering Recommendations (Peak Temperature) ^c			260	

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{a, d}	t ≤ 5 s	R _{thJA}	105	135	°C/W		
Maximum Junction-to-Ambient ^{b, e}	1 > 3 8		200	260	1 0,00		

Notes:

- a. Surface mounted on 1" x 1" FR4 board with full copper, t = 5 s.
- b. Surface mounted on 1" x 1" FR4 board with minimum copper, t = 5 s.
- c. Refer to IPC/JEDEC (J-STD-020), no manual or hand soldering.
- d. Maximum under steady state conditions is 185 °C/W.
- e. Maximum under steady state conditions is 330 °C/W.

Si8800EDB

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SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)								
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit		
Static	-		1	1	I.	,		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	20			V		
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$ $\Delta V_{GS(th)}/T_{J}$	L = 250 HA		18		mV/°C		
V _{GS(th)} Temperature Coefficient		I _D = 250 μA		- 2.3				
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	0.4		1	V		
Oata Oassa Laalana	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 4.5 \text{ V}$			± 0.5	μΑ		
Gate-Source Leakage		V _{DS} = 0 V, V _{GS} = ± 8 V			± 6			
Zone Cote Voltage Brain Comment		V _{DS} = 20 V, V _{GS} = 0 V			1			
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 20 V, V _{GS} = 0 V, T _J = 55 °C			10			
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	10			Α		
		$V_{GS} = 4.5 \text{ V}, I_D = 1 \text{ A}$		0.066	0.080			
	Б	$V_{GS} = 2.5 \text{ V}, I_D = 1 \text{ A}$		0.072	0.090			
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 1.8 V, I _D = 1 A		0.082	0.105	Ω		
		$V_{GS} = 1.5 \text{ V}, I_D = 0.5 \text{ A}$		0.095	0.150			
Forward Transconductance ^a	9 _{fs}	V _{DS} = 10 V, I _D = 1 A		10		S		
Dynamic ^b	•		•	•				
Total Gate Charge	Qg	V _{DS} = 10 V, V _{GS} = 8 V, I _D = 1 A		5.5	8.3	nC		
Total date offarge				3.2	5			
Gate-Source Charge	Q_{gs}	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 1 \text{ A}$		0.42				
Gate-Drain Charge	Q_{gd}			0.5				
Gate Resistance	R_g	f = 1 MHz		1		kΩ		
Turn-On Delay Time	t _{d(on)}			65	130			
Rise Time	t _r	V_{DD} = 10 V, R_L = 10 Ω		85	170	ns		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 1 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		900	1800			
Fall Time	t _f			350	700			
Turn-On Delay Time	t _{d(on)}			25	50			
Rise Time	t _r	$V_{DD} = 10 \text{ V}, R_{L} = 10 \Omega$		40	80			
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 1 \text{ A}, V_{GEN} = 8 \text{ V}, R_g = 1 \Omega$		1100	2200			
Fall Time	t _f			350	700			
Drain-Source Body Diode Characteristic	s							
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			0.7	Α		
Pulse Diode Forward Current	I _{SM}				15			
Body Diode Voltage	V_{SD}	$I_S = 1 A, V_{GS} = 0 V$		1	1.5	V		
Body Diode Reverse Recovery Time	t _{rr}			13	25	ns		
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 1 A, dl/dt = 100 A/μs, T _J = 25 °C		5	10	nC		
Reverse Recovery Fall Time	t _a			8		ns		
Reverse Recovery Rise Time	t _b			5				

Notes:

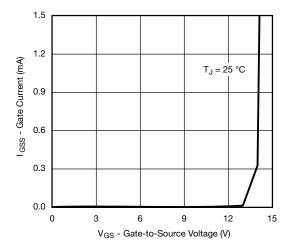
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %

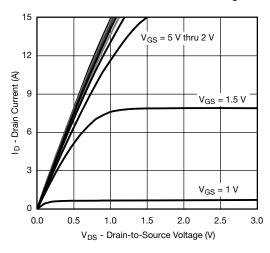
b. Guaranteed by design, not subject to production testing.



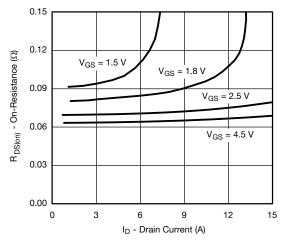
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



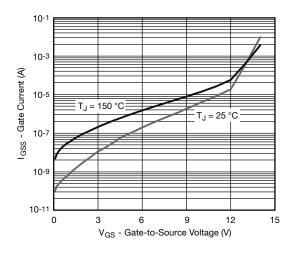
Gate Current vs. Gate-Source Voltage



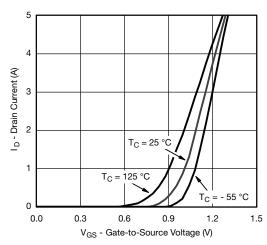
Output Characteristics



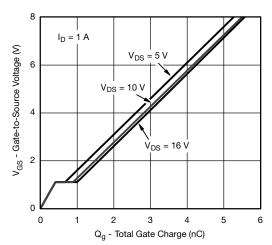
On-Resistance vs. Drain Current



Gate Current vs. Gate-Source Voltage



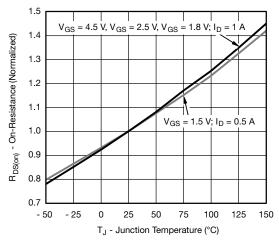
Transfer Characteristics



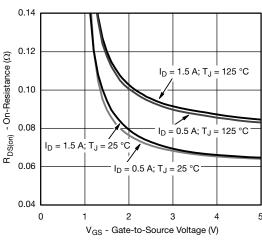
Gate Charge

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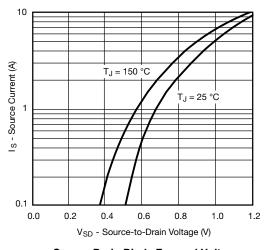
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



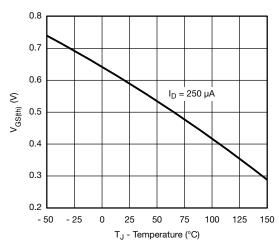
On-Resistance vs. Junction Temperature



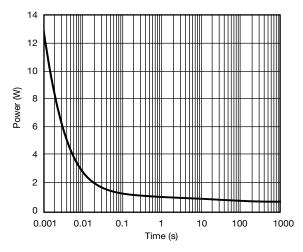
On-Resistance vs. Gate-to-Source Voltage



Source-Drain Diode Forward Voltage



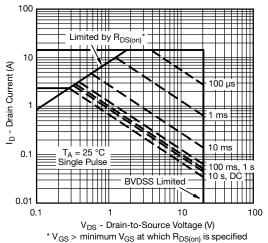
Threshold Voltage



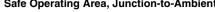
Single Pulse Power (Junction-to-Ambient)

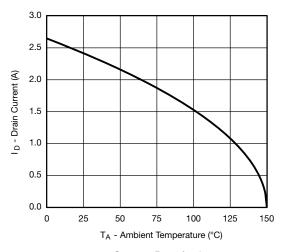


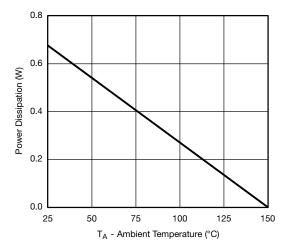
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Safe Operating Area, Junction-to-Ambient







Current Derating*

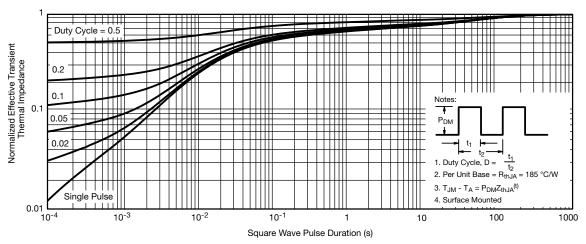
Power Derating

Note: When mounted on 1" x 1" FR4 with full copper.

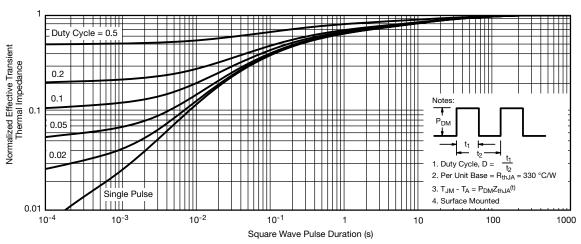
^{*} The power dissipation PD is based on TJ(max) = 150 °C, using junction-to-ambient thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient (On 1" x 1" FR4 board with maximum copper)

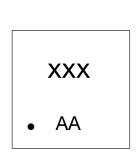


Normalized Thermal Transient Impedance, Junction-to-Ambient (on 1" x 1" FR4 board with minimum copper)

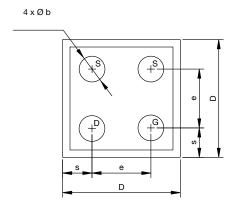


PACKAGE OUTLINE

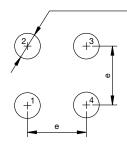
MICRO FOOT 0.8 mm x 0.8 mm: 4-BUMP (2 x 2, 0.4 mm PITCH)



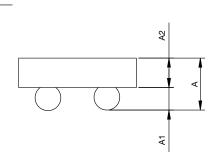
Mark on Backside of die



4 x Ø 0.205 to 0.225 Note 4 Solder Mask ~ Ø 0.215



Recommended Land



Notes (Unless otherwise specified):

- 1. All dimensions are in millimeters.
- 2. Four (4) solder bumps are lead (Pb)-free 95.5Sn/3.8Ag/0.7Cu with diameter Ø 0.165 mm to Ø 0.185 mm.
- 3. Backside surface is coated with a Ti/Ni/Ag layer.
- 4. Non-solder mask defined copper landing pad.
- 5. is location of pin 1.

Dim.	Millimeters ^a			Inches			
	Min.	Nom.	Max.	Min.	Nom.	Max.	
Α	0.314	0.357	0.400	0.0124	0.0141	0.0157	
A ₁	0.127	0.157	0.187	0.0050	0.0062	0.0074	
A ₂	0.187	0.200	0.213	0.0074	0.0079	0.0084	
b	0.165	0.175	0.185	0.0064	0.0068	0.0072	
е	0.400			0.0157			
s	0.180	0.200	0.220	0.0070	0.0078	0.0086	
D	0.760	0.800	0.840	0.0299	0.0314	0.0330	

a. Use millimeters as the primary measurement.

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